## Application/Control No. Applicant(s)/Patent Under Reexamination 10/652,493 CHOE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3742 Sang Y. Paik **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,728,223 03-1998 Murakami et al. 118/715 Α \* 02-2000 118/715 US-6,024,799 Chen et al. В US-С US-D US-Ε US-F US-G US-Н USı US-J US-K US-US-М FOREIGN PATENT DOCUMENTS

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